# **BUK962R1-40E**

## N-channel TrenchMOS logic level FET

13 July 2012

**Product data sheet** 

## 1. Product profile

#### 1.1 General description

Logic level N-channel MOSFET in a SOT404 package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

#### 1.2 Features and benefits

- AEC Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True logic level gate with Vgst(th) rating of greater than 0.5V at 175 °C

#### 1.3 Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

#### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol                  | Parameter                        | Conditions  |     | Min | Тур  | Max | Unit |  |
|-------------------------|----------------------------------|---|-----|-----|------|-----|------|--|
| $V_{DS}$                | drain-source voltage             | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C   |     | -   | -    | 40  | V    |  |
| I <sub>D</sub>          | drain current                    | V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>                             | [1] | -   | -    | 120 | Α    |  |
| P <sub>tot</sub>        | total power dissipation          | T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>  |     | -   | -    | 293 | W    |  |
| Static characte         | Static characteristics           |   |     |     |      |     |      |  |
| R <sub>DSon</sub>       | drain-source on-state resistance | $V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}; Fig. 11$                  |     | -   | 1.7  | 2.1 | mΩ   |  |
| Dynamic characteristics |                                  |   |     |     |      |     |      |  |
| $Q_{GD}$                | gate-drain charge                | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V;<br>Fig. 13; Fig. 14 |     | -   | 29.6 | -   | nC   |  |

[1] Continuous current is limited by package.





## 2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description                       | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--------------------|----------------|
| 1   | G      | gate                              | mb                 | D<br>I         |
| 2   | D      | drain                             |                    |                |
| 3   | S      | source                            |                    | G T T          |
| mb  | D      | mounting base; connected to drain | D2PAK (SOT404)     | mbb076 S       |

## 3. Ordering information

Table 3. Ordering information

| Type number  | Package |  |         |  |  |
|--------------|---------|--|---------|--|--|
|              | Name    | Description  | Version |  |  |
| BUK962R1-40E | D2PAK   | plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped) | SOT404  |  |  |

## 4. Marking

Table 4. Marking codes

| Type number  | Marking code |
|--------------|--------------|
| BUK962R1-40E | BUK962R1-40E |

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter               | Conditions  |     | Min | Max             | Unit               |
|------------------|-------------------------|---|-----|-----|-----------------|--------------------|
| V <sub>DS</sub>  | drain-source voltage    | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C                     |     | -   | 40              | V                  |
| $V_{DGR}$        | drain-gate voltage      | $R_{GS}$ = 20 k $\Omega$  |     | -   | 40              | V                  |
| $V_{GS}$         | gate-source voltage     | T <sub>j</sub> = 25 °C  |     | -10 | 10              | V                  |
|                  |                         | T <sub>j</sub> = 25 °C; lifetime =100 hours                         |     | -15 | 15              | V                  |
| I <sub>D</sub>   | drain current           | T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 5 V; <u>Fig. 1</u>       | [1] | -   | 120             | Α                  |
|                  |                         | T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 5 V; <u>Fig. 1</u>      | [1] | -   | 120             | Α                  |
| I <sub>DM</sub>  | peak drain current      | $T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \mu s$ ; Fig. 4               |     | -   | 1078            | Α                  |
| P <sub>tot</sub> | total power dissipation | T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>                              |     | -   | 293             | W                  |
| T <sub>stg</sub> | storage temperature     |   |     | -55 | 175             | °C                 |
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| Symbol               | Parameter                                    | Conditions   |        | Min | Max  | Unit |
|----------------------|--|--|--------|-----|------|------|
| Tj                   | junction temperature                         |  |        | -55 | 175  | °C   |
| Source-dra           | in diode                                     |  | 1      |     |      | ,    |
| I <sub>S</sub>       | source current                               | T <sub>mb</sub> = 25 °C  | [1]    | -   | 120  | Α    |
| I <sub>SM</sub>      | peak source current                          | pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$   |        | -   | 1078 | Α    |
| Avalanche            | ruggedness                                   |  | '      |     |      | ,    |
| E <sub>DS(AL)S</sub> | non-repetitive drain-source avalanche energy | $I_D$ = 120 A; $V_{sup} \le 40$ V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped; Fig. 3 | [2][3] | -   | 622  | mJ   |

- [1] Continuous current is limited by package.
- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.

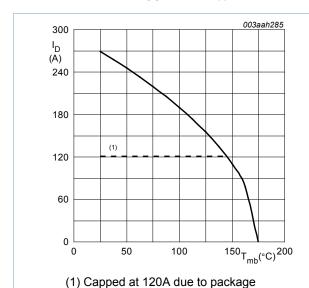


Fig. 1. Continuous drain current as a function of mounting base temperature

$$V_{GS} \ge 5V$$

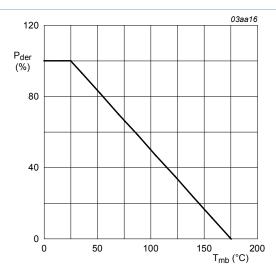


Fig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \,\%$$

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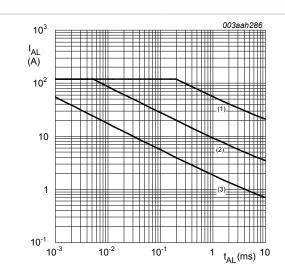
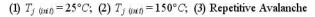


Fig. 3. Single pulse avalanche rating; avalanche current as a function of avalanche time



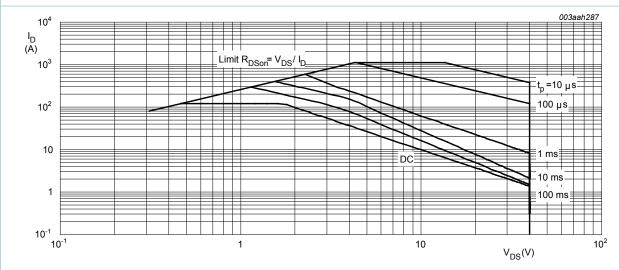


Fig. 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is a single pulse

#### 6. Thermal characteristics

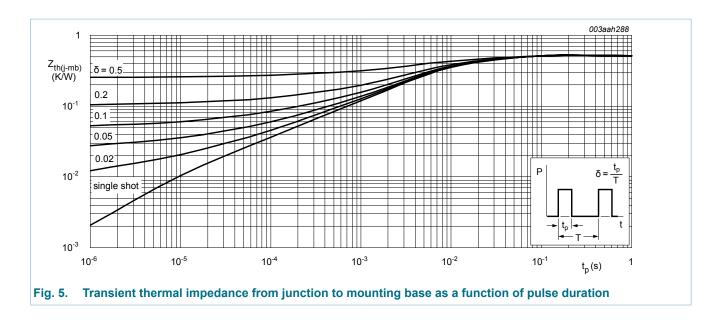
Table 6. Thermal characteristics

| Symbol                | Parameter   | Conditions   | Min | Тур | Max  | Unit |
|-----------------------|---|--|-----|-----|------|------|
| R <sub>th(j-mb)</sub> | thermal resistance<br>from junction to<br>mounting base | Fig. 5   | -   | -   | 0.51 | K/W  |
| R <sub>th(j-a)</sub>  | thermal resistance<br>from junction to<br>ambient       | minimum footprint ; mounted on a printed-circuit board | -   | 50  | -    | K/W  |

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### 7. Characteristics

Table 7. Characteristics

| Symbol              | Parameter                     | Conditions  | Min | Тур  | Max  | Unit |
|---------------------|-------------------------------|---|-----|------|------|------|
| Static chara        | acteristics                   |   |     |      |      | ,    |
| $V_{(BR)DSS}$       | drain-source                  | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$  | 40  | -    | -    | V    |
|                     | breakdown voltage             | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$   | 36  | -    | -    | V    |
| $V_{GS(th)}$        | gate-source threshold voltage | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$<br>Fig. 9; Fig. 10            | 1.4 | 1.7  | 2.1  | V    |
|                     |                               | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$<br>Fig. 9                    | -   | -    | 2.45 | V    |
|                     |                               | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$<br>Fig. 9                    | 0.5 | -    | -    | V    |
| I <sub>DSS</sub>    | drain leakage current         | V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C                     | -   | 0.15 | 1    | μA   |
|                     |                               | V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C                    | -   | -    | 500  | μΑ   |
| I <sub>GSS</sub>    | gate leakage current          | V <sub>GS</sub> = 10 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                     | -   | 2    | 100  | nA   |
|                     |                               | V <sub>GS</sub> = -10 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                    | -   | 2    | 100  | nA   |
| R <sub>DSon</sub>   | drain-source on-state         | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>      | -   | 1.7  | 2.1  | mΩ   |
| resistance          | resistance                    | $V_{GS}$ = 10 V; $I_{D}$ = 25 A; $T_{j}$ = 25 °C;<br>Fig. 11                              | -   | 1.5  | 1.8  | mΩ   |
|                     |                               | $V_{GS}$ = 5 V; $I_D$ = 25 A; $T_j$ = 175 °C;<br>Fig. 12; Fig. 11                         | -   | -    | 4    | mΩ   |
| Dynamic ch          | naracteristics                | ,   |     | 1    |      |      |
| Q <sub>G(tot)</sub> | total gate charge             | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V;<br>Fig. 13; Fig. 14 | -   | 87.8 | -    | nC   |

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| Symbol              | Parameter                    | Conditions  |  | Min | Тур  | Max   | Unit |
|---------------------|------------------------------|---|--|-----|------|-------|------|
| $Q_{GS}$            | gate-source charge           | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V;<br>Fig. 14; Fig. 13 |  | -   | 20.8 | -     | nC   |
| $Q_{GD}$            | gate-drain charge            | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V;<br>Fig. 13; Fig. 14 |  | -   | 29.6 | -     | nC   |
| C <sub>iss</sub>    | input capacitance            | V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz;                                 |  | -   | 9880 | 13160 | pF   |
| C <sub>oss</sub>    | output capacitance           | T <sub>j</sub> = 25 °C; <u>Fig. 15</u>  |  | -   | 1187 | 1425  | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance |   |  | -   | 600  | 820   | pF   |
| t <sub>d(on)</sub>  | turn-on delay time           | $V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 5 \text{ V};$                          |  | -   | 56   | -     | ns   |
| t <sub>r</sub>      | rise time                    | $R_{G(ext)} = 5 \Omega$   |  | -   | 96   | -     | ns   |
| t <sub>d(off)</sub> | turn-off delay time          |   |  | -   | 151  | -     | ns   |
| t <sub>f</sub>      | fall time                    |   |  | -   | 93   | -     | ns   |
| L <sub>D</sub>      | internal drain inductance    | from upper edge of drain mounting base to center of die                                   |  | -   | 2.5  | -     | nH   |
| L <sub>S</sub>      | internal source inductance   | from source lead to source bonding pad  |  | -   | 7.5  | -     | nΗ   |
| Source-dra          | nin diode                    |   |  |     |      |       | ,    |
| $V_{SD}$            | source-drain voltage         | $I_S$ = 25 A; $V_{GS}$ = 0 V; $T_j$ = 25 °C; <u>Fig. 16</u>                               |  | -   | 0.8  | 1.2   | V    |
| t <sub>rr</sub>     | reverse recovery time        | $I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;  |  | -   | 45   | -     | ns   |
| Q <sub>r</sub>      | recovered charge             | V <sub>DS</sub> = 25 V  |  | -   | 62   | -     | nC   |

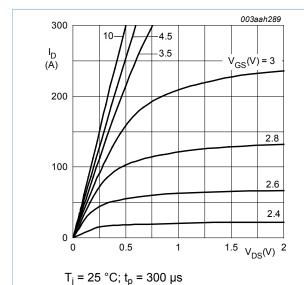


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

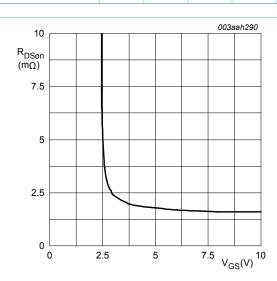


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

$$T_j = 25^{\circ}C; I_D = 25A$$

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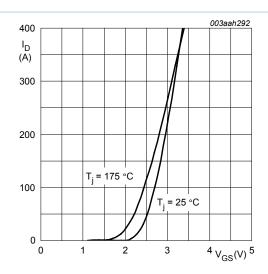


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values



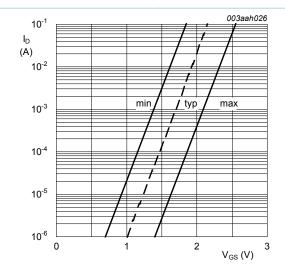


Fig. 10. Sub-threshold drain current as a function of gate-source voltage

$$T_j = 25$$
°C;  $V_{DS} = 5V$ 

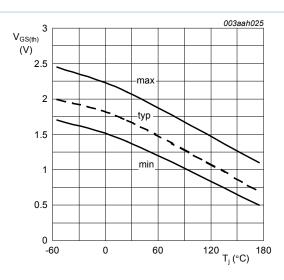
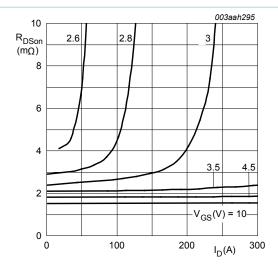


Fig. 9. Gate-source threshold voltage as a function of junction temperature

$$I_D = 1 \text{ mA}; \ V_{DS} = V_{GS}$$



 $T_j = 25 \, ^{\circ}C; t_p = 300 \, \mu s$ 

Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

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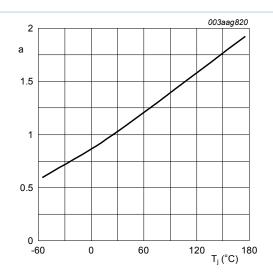


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

$$\mathbf{a} = \frac{R_{DSon}}{R_{DSon(25 \, ^{\circ}\!\!\!\!\!\!\!\mathbf{C})}}$$

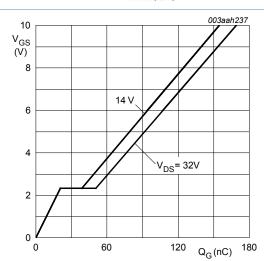


Fig. 14. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25^{\circ}C; I_D = 25A$$

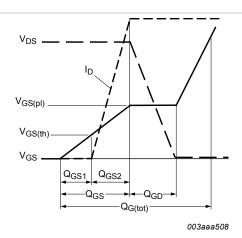


Fig. 13. Gate charge waveform definitions

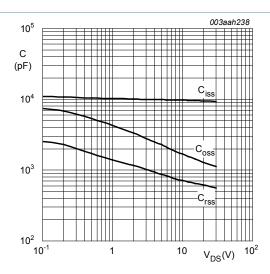


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = \mathbf{0}V; f = \mathbf{1}MHz$$

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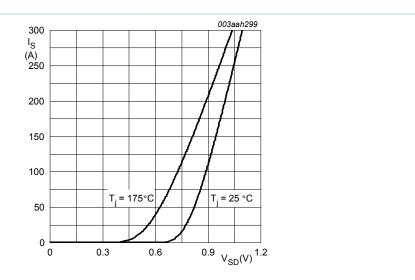


Fig. 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

$$V_{GS} = 0V$$

## 8. Package outline

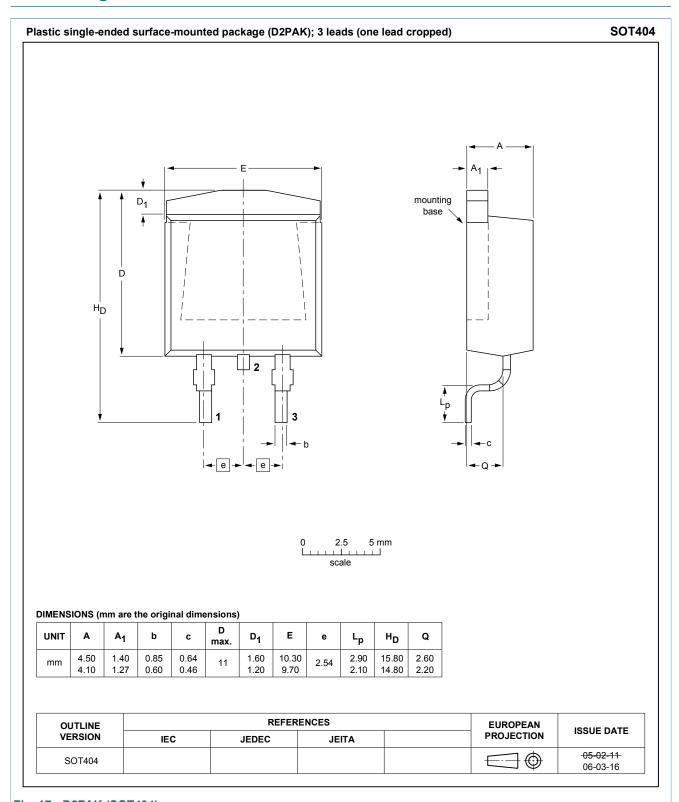


Fig. 17. D2PAK (SOT404)

### 9. Legal information

#### 9.1 Data sheet status

| Document status [1][2]               | Product status [3] | Definition  |
|--------------------------------------|--------------------|---|
| Objective<br>[short] data<br>sheet   | Development        | This document contains data from the objective specification for product development. |
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| Product<br>[short] data<br>sheet     | Production         | This document contains the product specification.                                     |

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